Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/786,489	OGIWARA, TOSHIAKI		
Examiner	Art Unit		
Mark Kopec	1751		

	SEARCHED					
Class	Subclass	Date	Examiner			
252	511	8/19/2006	M.K.			
252	512					
252	513					
252	514					
525	929					
528	312)				

INTERFERENCE SEARCHED						
Subclass	Date	Examiner				
	8/20/2006	M.K.				
		Subclass Date				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	D	ATE	EXMR		
STIC structure search	8/1	8/2006	M.K.		
EAST and CAS					
Inv. Name Search			1		